

TPS3613-01 ADJUSTABLE BATTERY-BACKUP SUPERVISOR FOR RAM RETENTION

SLVS340B – DECEMBER 2000 – REVISED DECEMBER 2002

- Supply Current of 40 μ A (Max)
- Battery Supply Current of 100 nA (Max)
- Supply Voltage Supervision Range:
 - Adjustable
 - Other Versions Available on Request
- Backup-Battery Voltage Can Exceed V_{DD}
- Power-On Reset Generator With Fixed 100-ms Reset Delay Time
- Active-High and Active-Low Reset Output
- Chip-Enable Gating . . . 3 ns (at $V_{DD} = 5$ V) Max Propagation Delay
- 10-Pin MSOP Package
- Temperature Range . . . -40°C to 85°C

typical applications

- Fax Machines
- Set-Top Boxes
- Advanced Voice Mail Systems
- Portable Battery Powered Equipment
- Computer Equipment
- Advanced Modems
- Automotive Systems
- Portable Long-Time Monitoring Equipment
- Point-of-Sale Equipment

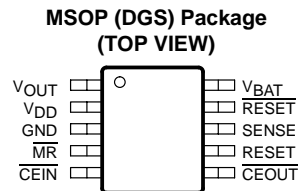
description

The TPS3613-01 supervisory circuit monitors and controls processor activity by providing backup-battery switchover for data retention of CMOS RAM.

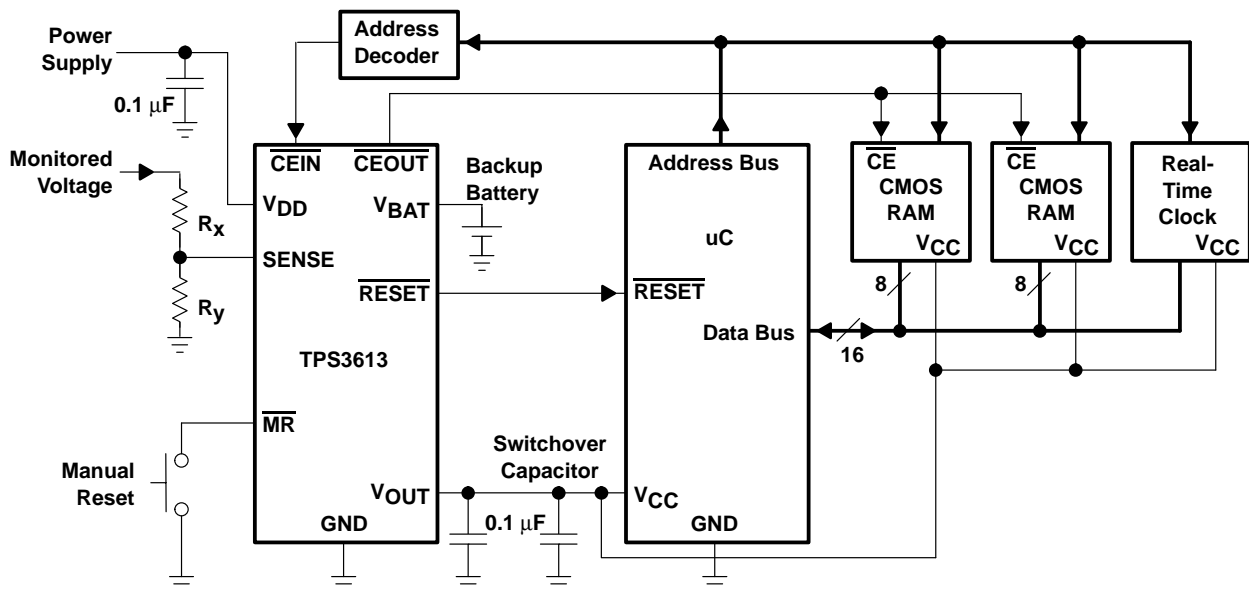
During power on, $\overline{\text{RESET}}$ is asserted when the supply voltage (V_{DD} or V_{BAT}) becomes higher than 1.1 V. Thereafter, the supply voltage supervisor monitors V_{DD} and keeps $\overline{\text{RESET}}$ output active as long as V_{DD} remains below the threshold voltage V_{IT} . An internal timer delays the return of the output to the inactive state (high) to ensure proper system reset. The delay time starts after V_{DD} has risen above the threshold voltage V_{IT} .

When the supply voltage drops below the threshold voltage V_{IT} , the output becomes active (low) again.

The TPS3613-01 is available in a 10-pin MSOP package and is characterized for operation over a temperature range of -40°C to 85°C .



typical operating circuit



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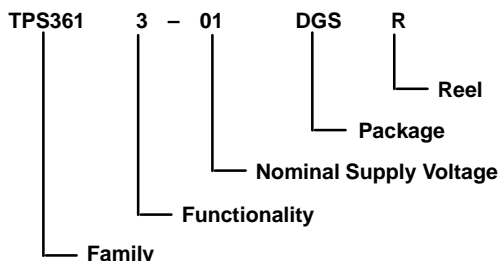
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PACKAGE INFORMATION

T _A	DEVICE NAME	MARKING
-40°C to 85°C	TPS3613-01DGS†	AFK

† The DGSR passive indicates tape and reel of 2500 parts.

ordering information application specific versions



DEVICE NAME	NOMINAL VOLTAGE‡, V _{NOM}
TPS3613-01 DGS	Adjustable

‡ For other threshold voltages, contact the local TI sales office for availability and lead-time.

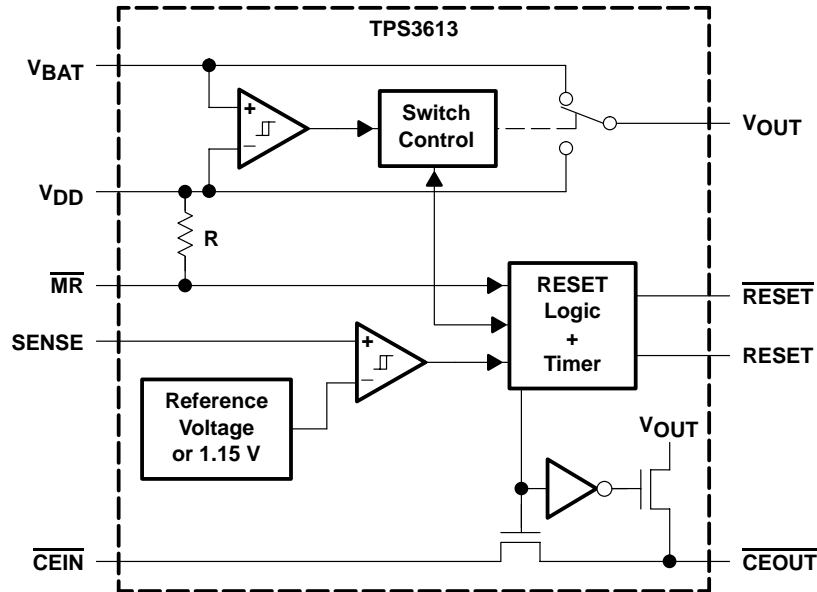
FUNCTION TABLE

SENSE > V _{IT}	V _{DD} > V _{BAT}	$\overline{\text{MR}}$	$\overline{\text{CEIN}}$	V _{OUT}	$\overline{\text{RESET}}$	RESET	$\overline{\text{CEOUT}}$
0	0	0	0	V _{BAT}	0	1	DIS
0	0	0	1	V _{BAT}	0	1	DIS
0	0	1	0	V _{BAT}	0	1	DIS
0	0	1	1	V _{BAT}	0	1	DIS
0	1	0	0	V _{DD}	0	1	DIS
0	1	0	1	V _{DD}	0	1	DIS
0	1	1	0	V _{DD}	0	1	DIS
0	1	1	1	V _{DD}	0	1	DIS
1	0	0	0	V _{DD}	0	1	DIS
1	0	0	1	V _{DD}	0	1	DIS
1	0	1	0	V _{DD}	1	0	DIS
1	0	1	1	V _{DD}	1	0	EN
1	1	0	0	V _{DD}	0	1	DIS
1	1	0	1	V _{DD}	0	1	DIS
1	1	1	0	V _{DD}	1	0	DIS
1	1	1	1	V _{DD}	1	0	EN

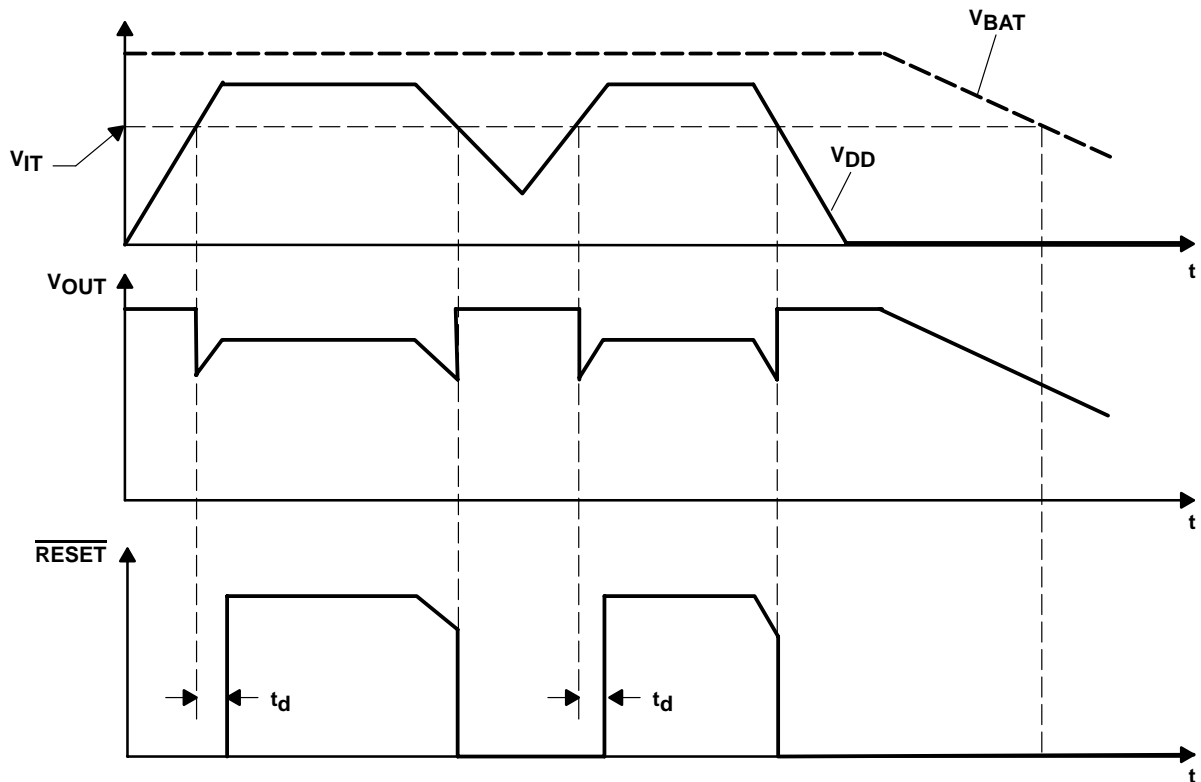
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functional schematic



timing diagram



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Terminal Functions

TERMINAL NAME	NO.	I/O	DESCRIPTION
$\overline{\text{CEIN}}$	5	I	Chip-enable input
$\overline{\text{CEOUT}}$	6	O	Chip-enable output
GND	3	I	Ground
$\overline{\text{MR}}$	4	I	Manual reset input
RESET	7	O	Active-high reset output
$\overline{\text{RESET}}$	9	O	Active-low reset output
SENSE	8	I	Adjustable sense input
V _{BAT}	10	I	Backup-battery input
V _{DD}	2	I	Input supply voltage
V _{OUT}	1	O	Supply output

detailed description

backup-battery switchover

In case of a brownout or power failure, it may be necessary to preserve the contents of RAM. If a backup battery is installed at V_{BAT}, the device automatically switches the connected RAM to backup power when V_{DD} fails. In order to allow the backup battery (e.g., 3.6-V lithium cells) to have a higher voltage than V_{DD}, these supervisors do not connect V_{BAT} to V_{OUT} when V_{BAT} is greater than V_{DD}. V_{BAT} only connects to V_{OUT} (through a 15-Ω switch) when V_{DD} falls below V_{IT} and V_{BAT} is greater than V_{DD}. When V_{DD} recovers, switchover is deferred either until V_{DD} crosses V_{BAT}, or when V_{DD} rises above the reset threshold V_{IT}. V_{OUT} connects to V_{DD} through a 1-Ω (max) PMOS switch when V_{DD} crosses the reset threshold.

V _{DD} >V _{BAT}	V _{DD} >V _{IT}	V _{OUT}
1	1	V _{DD}
1	0	V _{DD}
0	1	V _{DD}
0	0	V _{BAT}

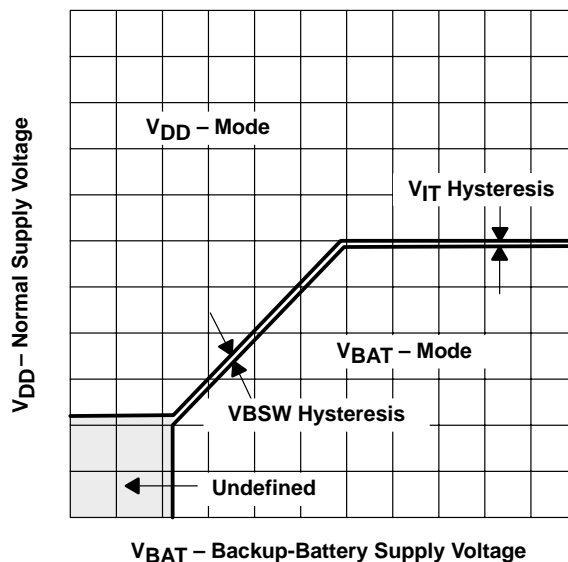


Figure 1. V_{DD} - V_{BAT} Switchover

detailed description (continued)

chip-enable signal gating

The internal gating of chip-enable (CE) signals prevents erroneous data from corrupting CMOS RAM during an under-voltage condition. The TPS3613 use a series transmission gate from \overline{CEIN} to \overline{CEOUT} . During normal operation (reset not asserted), the CE transmission gate is enabled and passes all CE transitions. When reset is asserted, this path becomes disabled, preventing erroneous data from corrupting the CMOS RAM. The short CE propagation delay from \overline{CEIN} to \overline{CEOUT} enables the TPS3613 device to be used with most processors.

The CE transmission gate is disabled and \overline{CEIN} is high impedance (disable mode) while reset is asserted. During a power-down sequence when V_{DD} crosses the reset threshold, the CE transmission gate is disabled and \overline{CEIN} immediately becomes high impedance if the voltage at \overline{CEIN} is high. If \overline{CEIN} is low when reset is asserted, the CE transmission gate is disabled when \overline{CEIN} goes high, or 15 μs after reset asserts, whichever occurs first. This allows the current write cycle to complete during power down. When the CE transmission gate is enabled, the impedance of \overline{CEIN} appears as a resistor in series with the load at \overline{CEOUT} . The overall device propagation delay through the CE transmission gate depends on V_{OUT} , the source impedance of the drive connected to \overline{CEIN} , and the load at \overline{CEOUT} . To achieve minimum propagation delay, the capacitive load at \overline{CEOUT} should be minimized, and a low-output-impedance driver is used.

In the disabled mode, the transmission gate is off and an active pullup connects \overline{CEOUT} to V_{OUT} . This pullup turns off when the transmission gate is enabled.

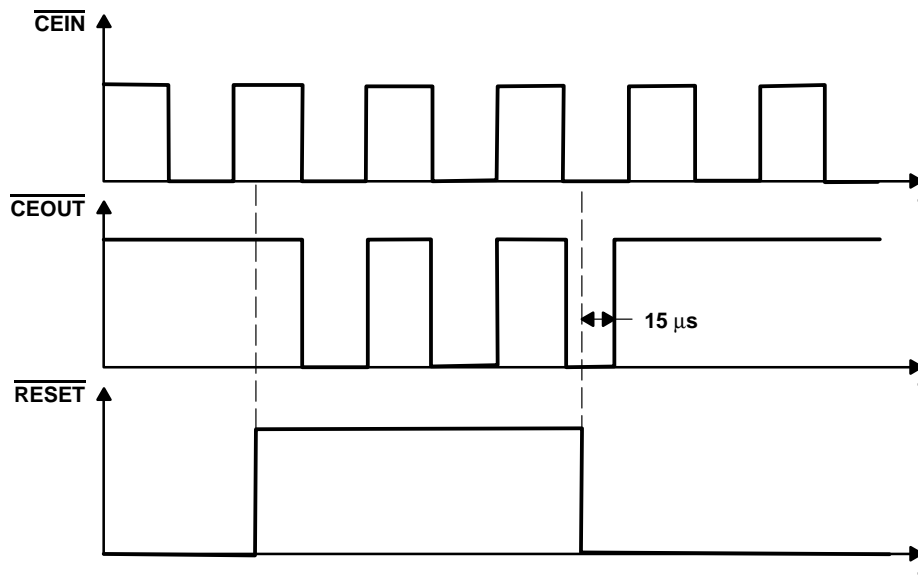


Figure 2. Chip-Enable Timing

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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage: V_{DD} (see Note1)	7 V
\overline{MR} and SENSE pins (see Note 1)	-0.3 V to ($V_{DD} + 0.3$ V)
Continuous output current at V_{OUT} : I_O	400 mA
All other pins, I_O	±10 mA
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, T_A	-40°C to 85°C
Storage temperature range, T_{stg}	-65°C to 150°C
Lead temperature soldering 1,6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to GND. For reliable operation the device must not be operated at 7 V for more than $t=1000h$ continuously.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING	$T_A = 85^\circ\text{C}$ POWER RATING
DGS	424 mW	3.4 mW/°C	271 mW	220 mW

recommended operating conditions

	MIN	MAX	UNIT
Supply voltage, V_{DD}	1.65	5.5	V
Battery supply voltage, V_{BAT}	1.5	5.5	V
Input voltage, V_I	0	$V_{DD} + 0.3$	V
High-level input voltage, V_{IH}	$0.7 \times V_{DD}$		V
Low-level input voltage, V_{IL}		$0.3 \times V_{DD}$	V
Continuous output current at V_{OUT} , I_O		300	mA
Input transition rise and fall rate at \overline{MR} , $\Delta t/\Delta V$		100	ns/V
Slew rate at V_{DD} or V_{bat}		1	V/ μs
Operating free-air temperature range, T_A	-40	85	°C



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electrical characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{OH}	High-level output voltage	RESET V _{DD} = 1.8 V, I _{OH} = -400 μA V _{DD} = 3.3 V, I _{OH} = -2 mA V _{DD} = 5 V, I _{OH} = -3 mA	V _{DD} - 0.2 V			V
			V _{DD} - 0.4 V			
	RESET	V _{DD} = 1.8 V, I _{OH} = -20 μA	V _{DD} - 0.3 V			
		V _{DD} = 3.3 V, I _{OH} = -80 μA V _{DD} = 5 V, I _{OH} = -120 μA	V _{DD} - 0.4 V			
	CEOUT	V _{OUT} = 1.8 V, I _{OH} = -1 mA	V _{OUT} - 0.2 V			
	Enable mode CEIN = V _{OUT}	V _{OUT} = 3.3 V, I _{OH} = -2 mA V _{OUT} = 5 V, I _{OH} = -5 mA	V _{OUT} - 0.3 V			
CEOUT Disable mode	V _{OUT} = 3.3 V, I _{OH} = -0.5 mA	V _{OUT} - 0.4 V				
V _{OL}	Low-level output voltage	RESET V _{DD} = 1.8 V, I _{OL} = 400 μA				0.2
		RESET V _{DD} = 3.3 V, I _{OL} = 2 mA V _{DD} = 5 V, I _{OL} = 3 mA				0.4
		CEOUT V _{OUT} = 1.8 V, I _{OL} = 1.0 mA				0.2
		Enable mode CEIN = 0 V V _{OUT} = 3.3 V, I _{OL} = 2 mA V _{OUT} = 5 V, I _{OL} = 5 mA				0.3
V _{res}	Power-up reset voltage (see Note 2)	V _{DD} > 1.1 V or V _{BAT} > 1.1 V, I _{OL} = 20 μA				0.4
V _{OUT}	Normal mode	I _O = 8.5 mA, V _{DD} = 1.8 V, V _{BAT} = 0 V	V _{DD} - 50 mV			V
		I _O = 125 mA, V _{DD} = 3.3 V, V _{BAT} = 0 V	V _{DD} - 150 mV			
		I _O = 200 mA, V _{DD} = 5 V, V _{BAT} = 0 V	V _{DD} - 200 mV			
	Battery-backup mode	I _O = 0.5 mA, V _{BAT} = 1.5 V, V _{DD} = 0 V	V _{BAT} - 20 mV			
		I _O = 7.5 mA, V _{BAT} = 3.3 V, V _{DD} = 0 V	V _{BAT} - 113 mV			
R _{DSON}	V _{DD} to V _{OUT} on-resistance	V _{DD} = 5 V	0.6			Ω
	V _{BAT} to V _{OUT} on-resistance	V _{BAT} = 3.3 V	8			
V _{IT}	Negative-going input threshold voltage (see Note 3)		1.13	1.15	1.17	V
V _{hys}	Hysteresis	Sense	1.1 V < V _{IT} < 1.65 V			12
		V _{BSW} (see Note 4)	V _{DD} = 1.8 V			55
I _{IH}	High-level input current	MR	MR = 0.7 × V _{DD} , V _{DD} = 5 V			-33
I _{IL}	Low-level input current		MR = 0 V, V _{DD} = 5 V			-110
I _I	Input current	SENSE	V _{DD} = 1.15 V			-25
I _{DD}	V _{DD} supply current	V _{OUT} = V _{DD}				40
		V _{OUT} = V _{BAT}				40
I _{BAT}	V _{BAT} supply current	V _{OUT} = V _{DD}	-0.1			0.1
		V _{OUT} = V _{BAT}				0.5
I _{Ikg}	CEIN leakage current	Disable mode, V _I < V _{DD}				±1
C _i	Input capacitance	V _I = 0 V to 5 V				5

- NOTES: 2. The lowest supply voltage at which RESET becomes active. $t_r(V_{DD}) \geq 15 \mu s/V$.
3. To ensure best stability of the threshold voltage, a bypass capacitor (ceramic, 0.1 μF) should be placed near to the supply terminals.
4. For V_{DD} < 1.6 V, V_{OUT} switches to V_{BAT} regardless of V_{BAT}



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timing requirements at $R_L = 1\text{ M}\Omega$, $C_L = 50\text{ pF}$, $T_A = -40^\circ\text{C}$ to 85°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_w	Pulse width	SENSE $V_{IH} = V_{IT} + 0.2\text{ V}$, $V_{IL} = V_{IT} - 0.2\text{ V}$	6			μs

switching characteristics at $R_L = 1\text{ M}\Omega$, $C_L = 50\text{ pF}$, $T_A = -40^\circ\text{C}$ to 85°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_d	Delay time	$V_{SENSE} \geq V_{IT} + 0.2\text{ V}$, $\overline{MR} \geq 0.7 \times V_{DD}$, See timing diagram	60	100	140	ms
t_{PLH}	Propagation (delay) time, low-to-high-level output	50% \overline{RESET} to 50% $\overline{CEO_{OUT}}$ $V_{OUT} = V_{IT}$		15		μs
t_{PHL}	Propagation (delay) time, high-to-low-level output	$V_{DD} = 1.8\text{ V}$		5	15	ns
		$V_{DD} = 3.3\text{ V}$		1.6	5	
		$V_{DD} = 5\text{ V}$		1	3	
		SENSE to \overline{RESET}	$V_{IL} = V_{IT} - 0.2\text{ V}$, $V_{IH} = V_{IT} + 0.2\text{ V}$		2	5
	\overline{MR} to \overline{RESET}	$V_{SENSE} \geq V_{IT} + 0.2\text{ V}$, $V_{IL} = 0.3 \times V_{DD}$, $V_{IH} = 0.7 \times V_{DD}$		0.1	1	μs
Transition time	V_{DD} to V_{BAT}	$V_{IH} = V_{BAT} + 0.2\text{ V}$, $V_{IL} = V_{BAT} - 0.2\text{ V}$, $V_{BAT} < V_{IT}$			3	μs

NOTE 5: Assured by design



TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
$r_{DS(on)}$	Static drain-source on-state resistance (V_{DD} to V_{OUT})	vs Output current	3
	Static drain-source on-state resistance (V_{BAT} to V_{OUT})	vs Output current	4
	Static drain-source on-state resistance (\overline{CEIN} to \overline{CEOUT})	vs Input voltage at \overline{CEIN}	5
I_{DD}	Supply current	vs Supply voltage	6
V_{IT}	Input threshold voltage at \overline{RESET}	vs Free-air temperature	7
V_{OH}	High-level output voltage at \overline{RESET}	vs High-level output current	8, 9
	High-level output voltage at \overline{CEOUT}		10, 11, 12, 13
V_{OL}	Low-level output voltage at \overline{RESET}	vs Low-level output current	14, 15
	Low-level output voltage at \overline{CEOUT}	vs Low-level output current	16, 17

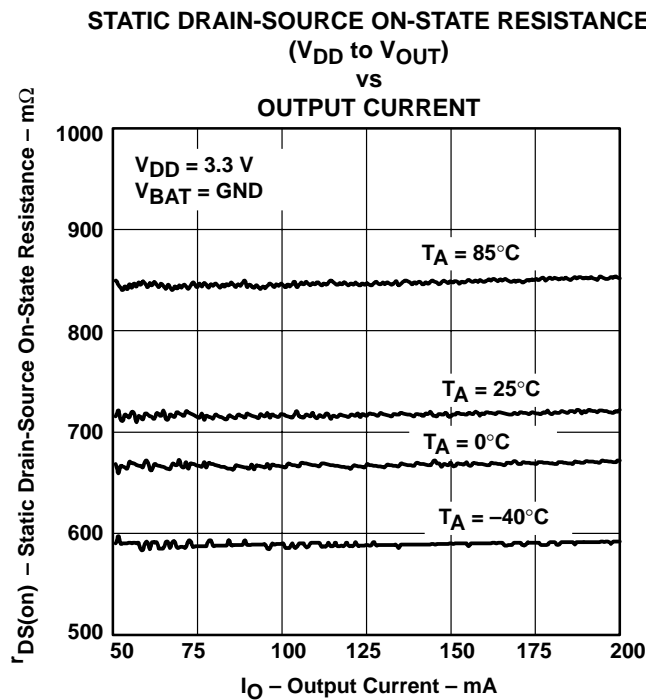


Figure 3

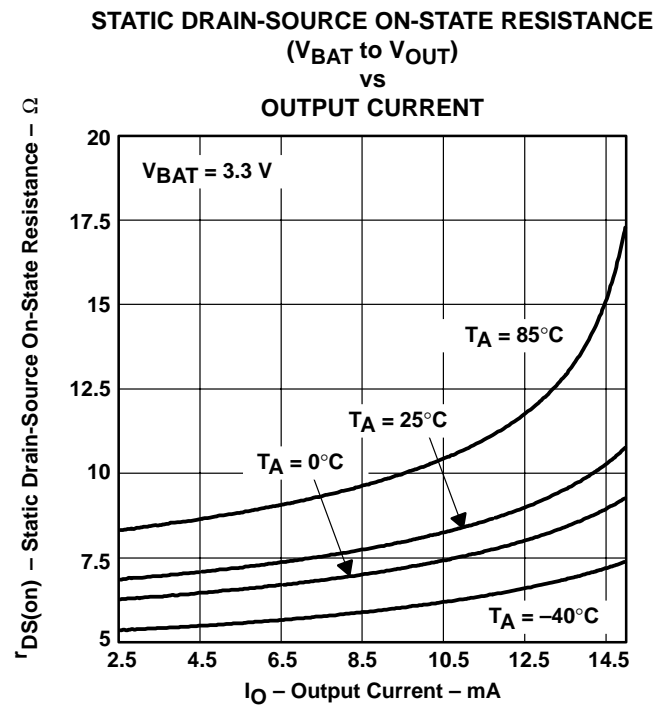


Figure 4

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TYPICAL CHARACTERISTICS

STATIC DRAIN-SOURCE ON-STATE RESISTANCE
(\overline{CEIN} to \overline{CEOUT})
vs
INPUT VOLTAGE AT \overline{CEIN}

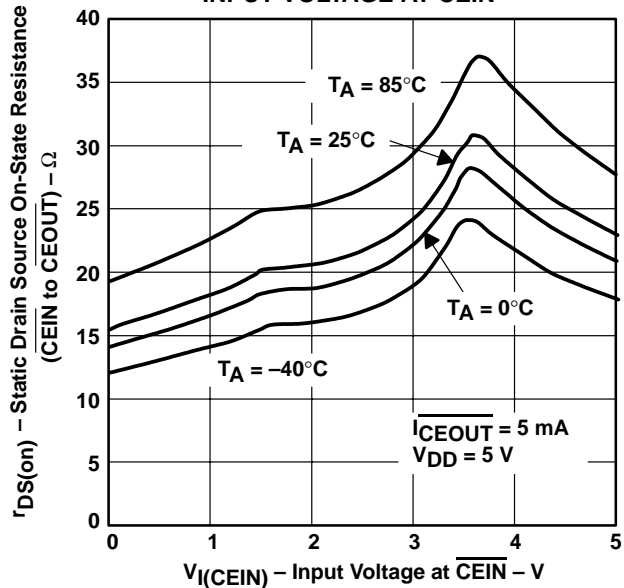


Figure 5

SUPPLY CURRENT
vs
SUPPLY VOLTAGE

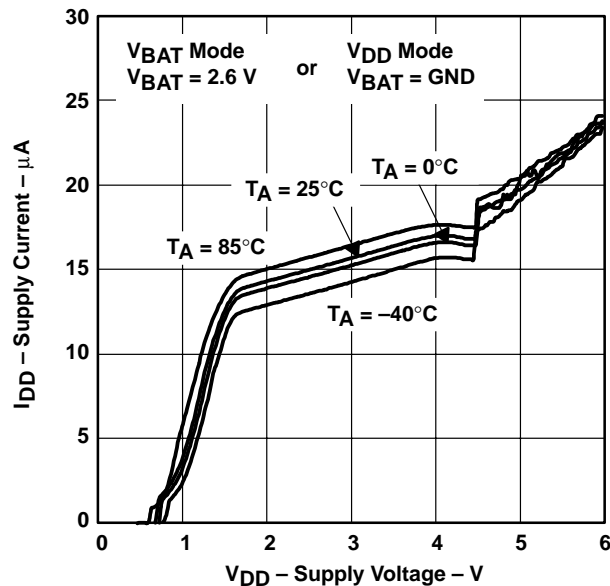


Figure 6

INPUT THRESHOLD VOLTAGE AT \overline{RESET}
vs
FREE-AIR TEMPERATURE

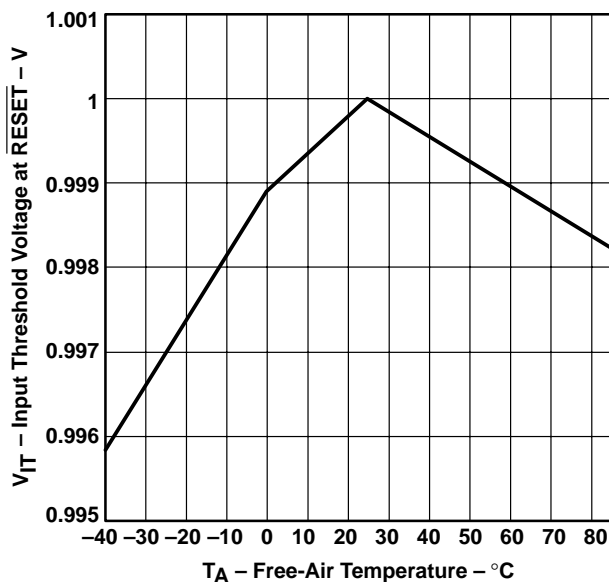


Figure 7

TYPICAL CHARACTERISTICS

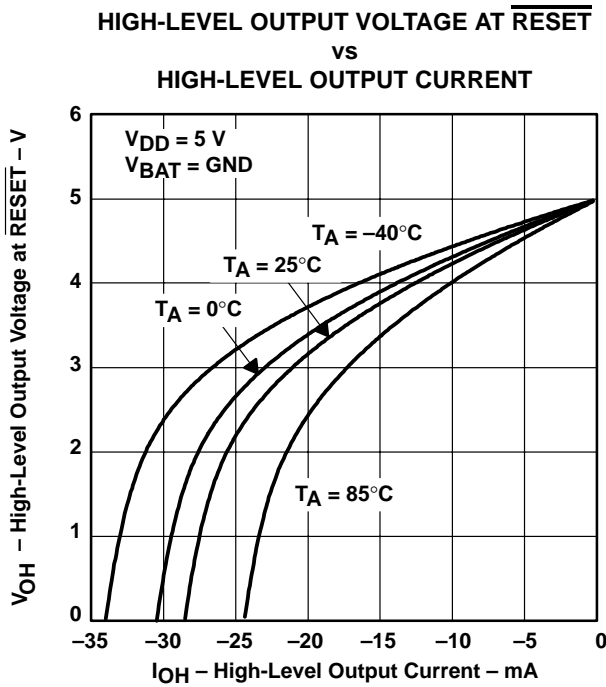


Figure 8

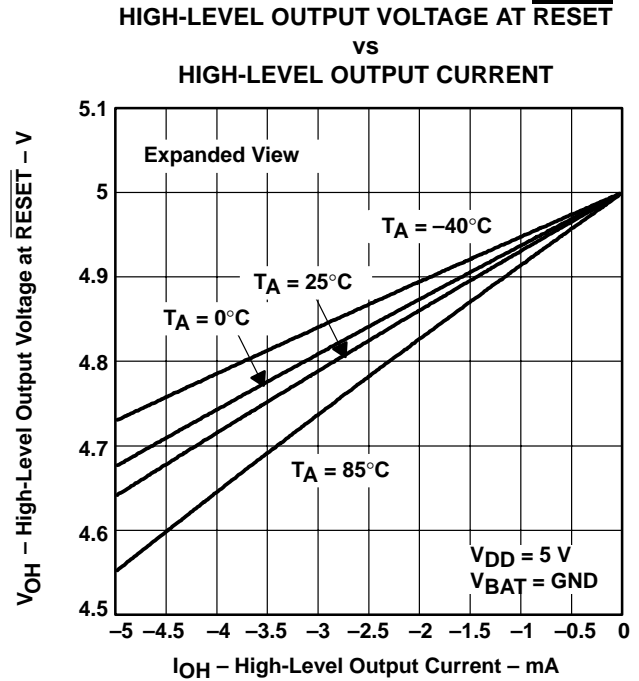


Figure 9

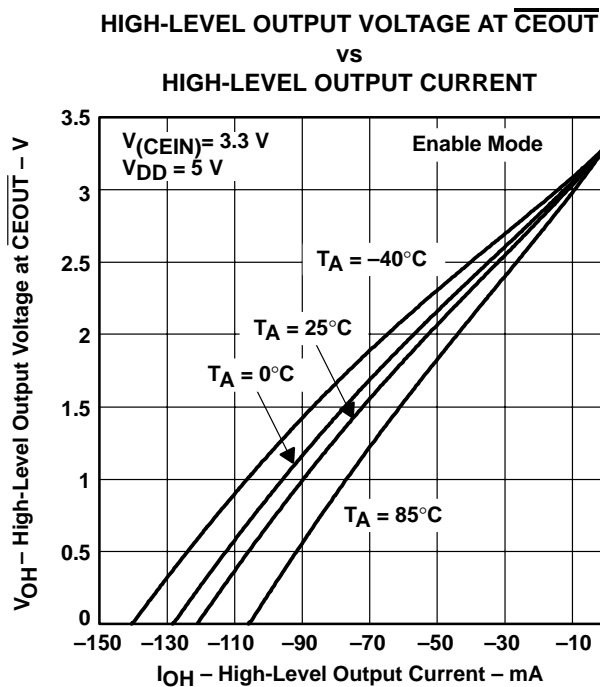


Figure 10

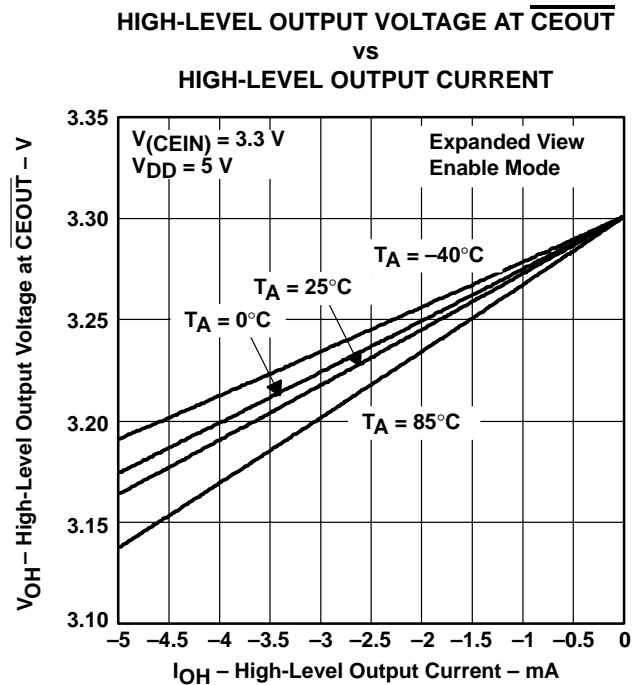


Figure 11

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TYPICAL CHARACTERISTICS

HIGH-LEVEL OUTPUT VOLTAGE AT $\overline{\text{CEOUT}}$
vs
HIGH-LEVEL OUTPUT CURRENT

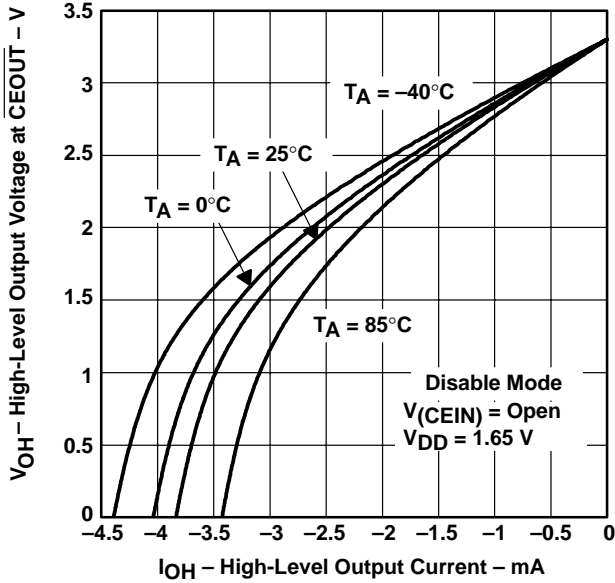


Figure 12

HIGH-LEVEL OUTPUT VOLTAGE AT $\overline{\text{CEOUT}}$
vs
HIGH-LEVEL OUTPUT CURRENT

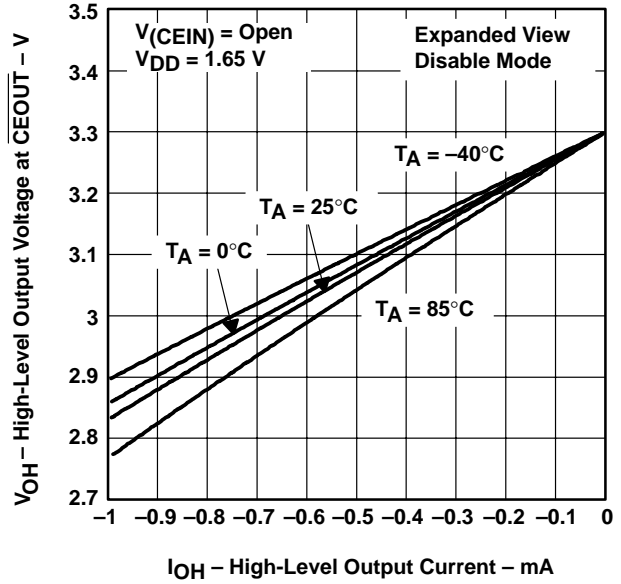


Figure 13

LOW-LEVEL OUTPUT VOLTAGE AT $\overline{\text{RESET}}$
vs
LOW-LEVEL OUTPUT CURRENT

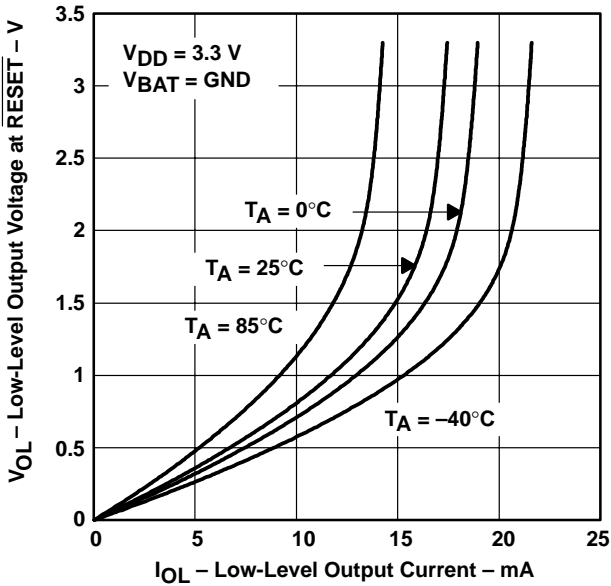


Figure 14

LOW-LEVEL OUTPUT VOLTAGE AT $\overline{\text{RESET}}$
vs
LOW-LEVEL OUTPUT CURRENT

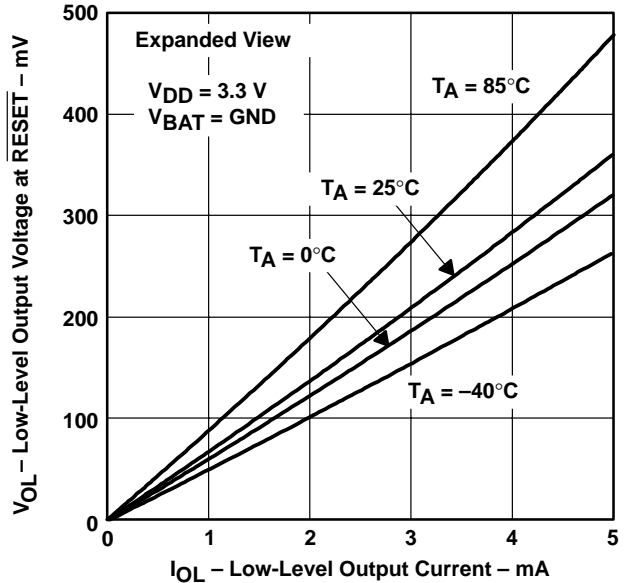


Figure 15

TYPICAL CHARACTERISTICS

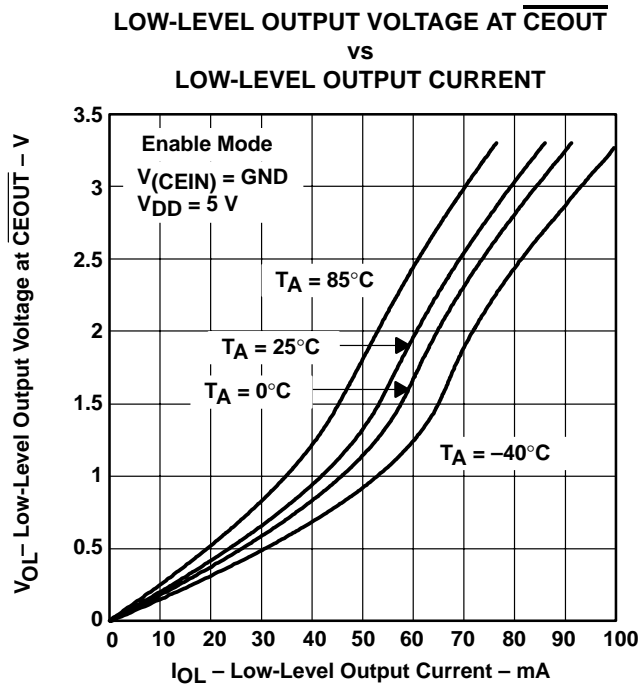


Figure 16

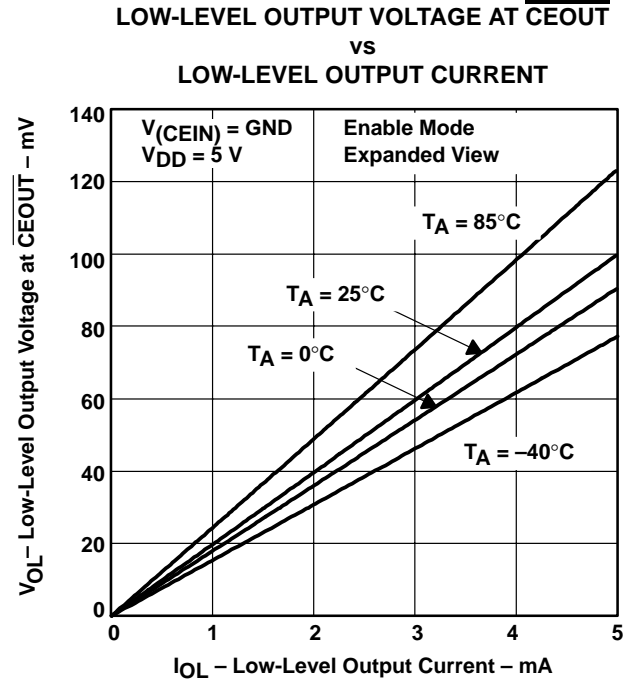


Figure 17

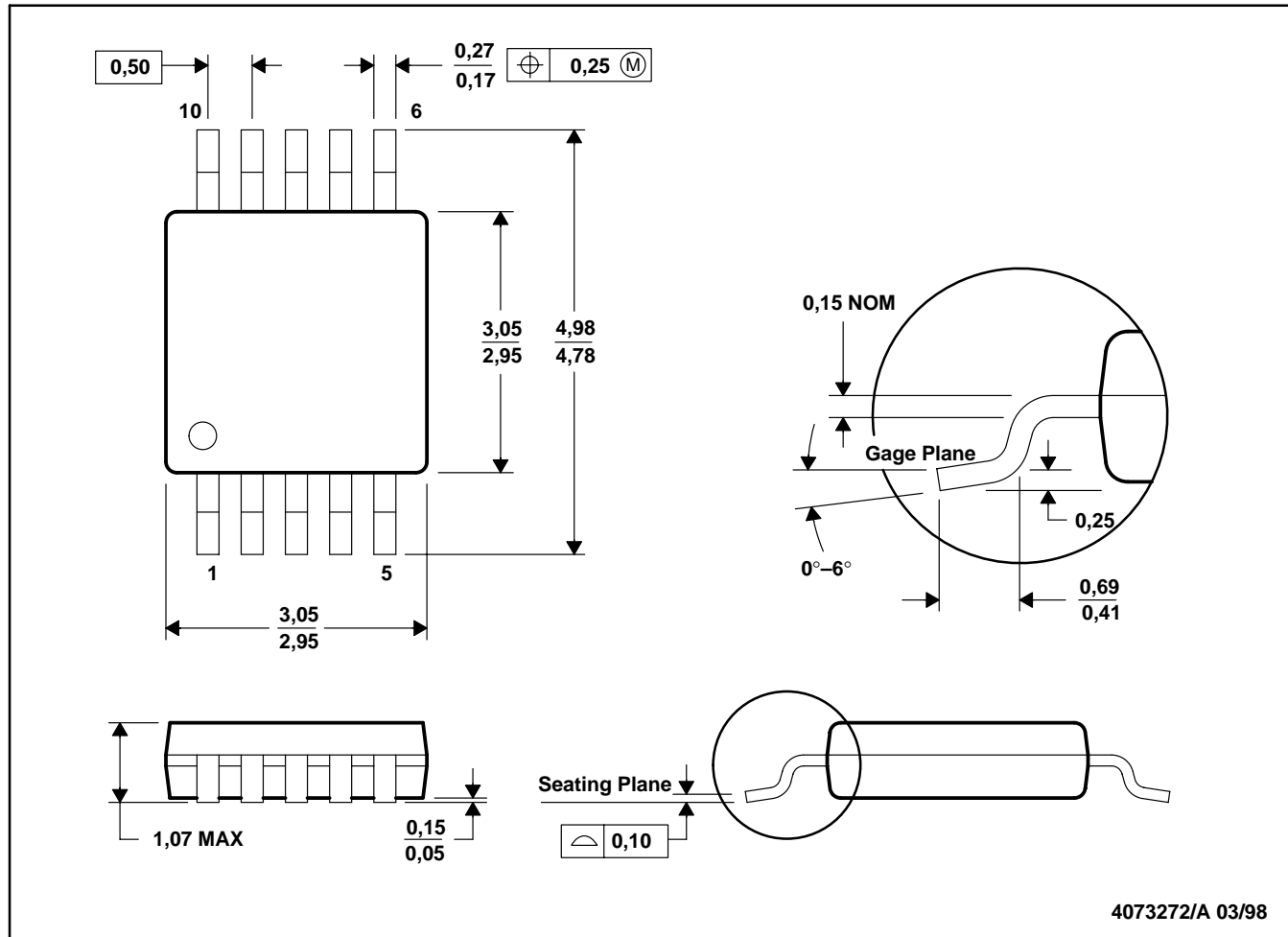
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MECHANICAL DATA

DGS (S-PDSO-G10)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion.

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